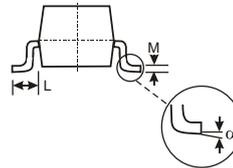
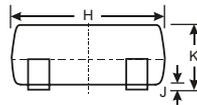
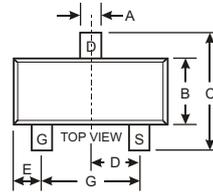


### Features

- High power and current handing capability.
- Lead free product is acquired.
- Super high density cell design for extremely low  $R_{DS(ON)}$ .
- Exceptional on-resistance and maximum DC current capability.
- We declare that the material of product compliance with RoHS requirements.



SOT-23		
Dim	Min	Max
A	0.37	0.51
B	1.20	1.40
C	2.30	2.50
D	0.89	1.03
E	0.45	0.60
G	1.78	2.05
H	2.80	3.00
J	0.013	0.10
K	0.903	1.10
L	0.45	0.61
M	0.085	0.180
$\alpha$	0°	8°
All Dimensions in mm		

### APPLICATIONS

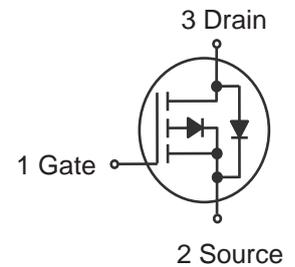
- Power Management in Notebook.
- Portable equipment.
- Battery powered system.
- Load switch.
- Marking Code:3407 OR A79T.

### Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current	$I_D$	-4.1	A
Peak Drain Current <sup>1)</sup>	$I_{DM}$	-20	A
Power Dissipation	$P_{tot}$	1.4	W
Thermal Resistance from Junction to Ambient (PCB mounted) <sup>2)</sup>	$R_{\theta JA}$	89	$^\circ\text{C}/\text{W}$
Junction Temperature	$T_J$	150	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	- 55 to + 150	$^\circ\text{C}$

<sup>1)</sup> Repetitive Rating: Pulse width limited by the Maximum junction temperature.

<sup>2)</sup> 1 in<sup>2</sup> 2oz Cu PCB board.



**Electrical Characteristics** @  $T_A = 25^\circ\text{C}$  unless otherwise specified

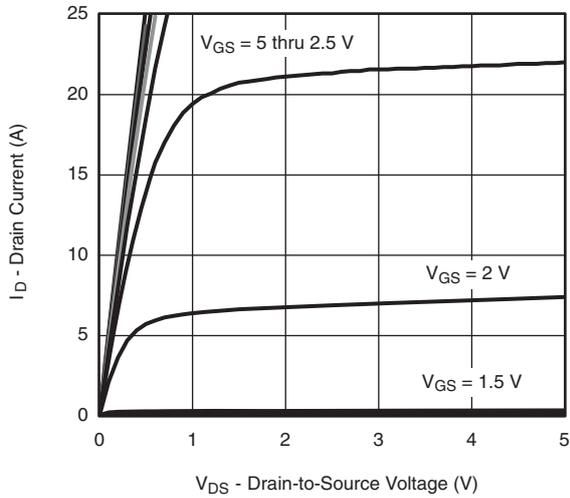
Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Static characteristics</b>						
Drain-source breakdown voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = -30V, V_{GS} = 0V$			-1	$\mu A$
Gate-source leakage current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
Drain-source on-resistance (note 1)	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -4.1A$		43	65	m $\Omega$
		$V_{GS} = -4.5V, I_D = -3.0A$		63	90	m $\Omega$
Forward transconductance (note 1)	$g_{FS}$	$V_{DS} = -5V, I_D = -4A$		5.5		S
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1.0	-1.5	-2.2	V
Diode forward voltage (note 1)	$V_{SD}$	$I_S = -1A, V_{GS} = 0V$			-1	V
<b>Dynamic characteristics (note 2)</b>						
Input capacitance	$C_{iss}$	$V_{DS} = -15V, V_{GS} = 0V, f = 1MHz$		700		pF
Output capacitance	$C_{oss}$			120		pF
Reverse transfer capacitance	$C_{rss}$			75		pF
<b>Switching Characteristics (note 2)</b>						
Turn-on delay time	$t_{d(on)}$	$V_{GS} = -10V, V_{DS} = -15V,$ $R_L = 3.6\Omega, R_{GEN} = 3\Omega$		9		ns
Turn-on rise time	$t_r$			5		ns
Turn-off delay time	$t_{d(off)}$			28		ns
Turn-off fall time	$t_f$			13.5		ns

**Notes:**

1. Pulse test: Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
2. These parameters have no way to verify.

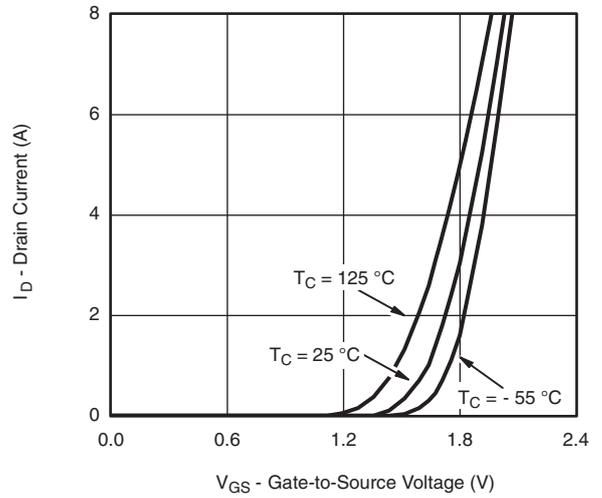


### TYPICAL TRANSIENT CHARACTERISTICS



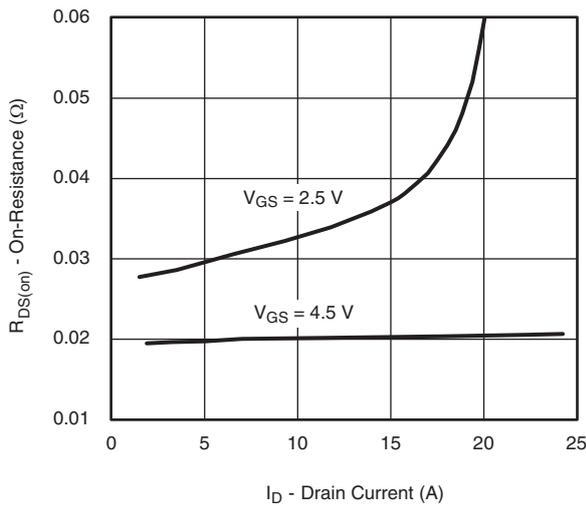
$V_{DS}$  - Drain-to-Source Voltage (V)

**Output Characteristics**



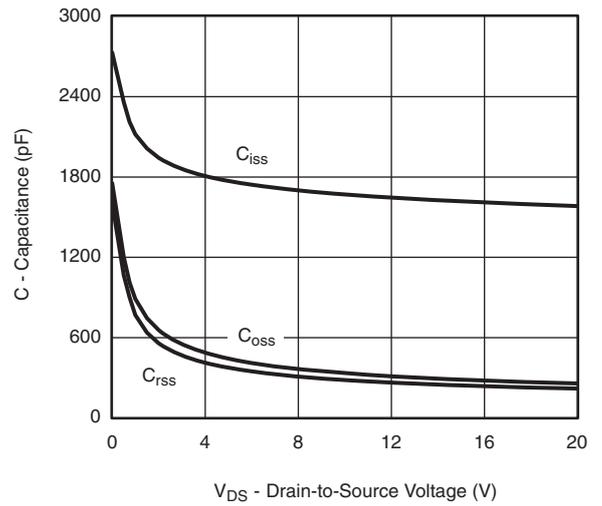
$V_{GS}$  - Gate-to-Source Voltage (V)

**Transfer Characteristics**



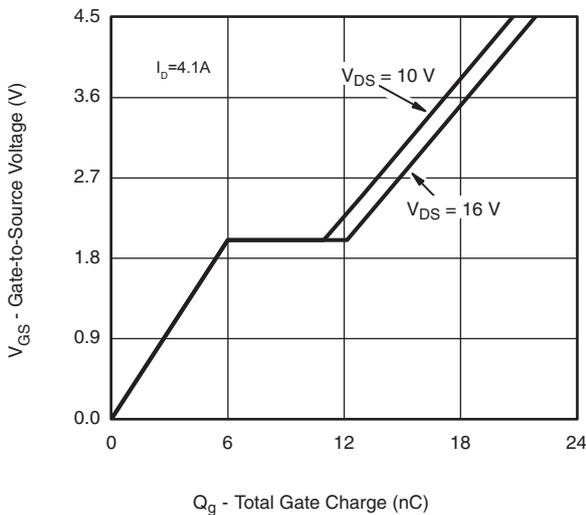
$I_D$  - Drain Current (A)

**On-Resistance vs. Drain Current and Gate Voltage**



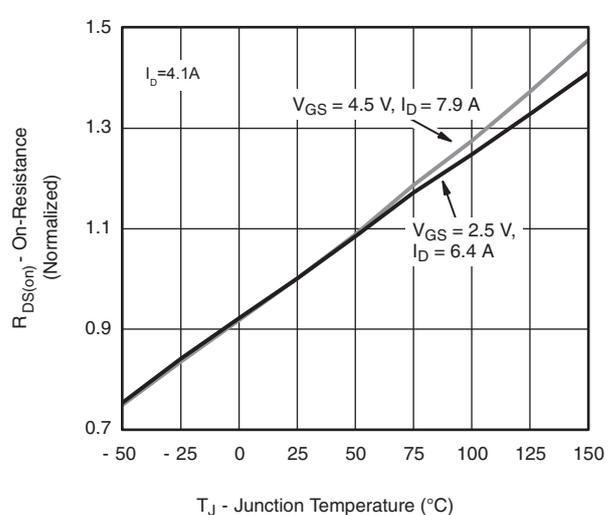
$V_{DS}$  - Drain-to-Source Voltage (V)

**Capacitance**



$Q_g$  - Total Gate Charge (nC)

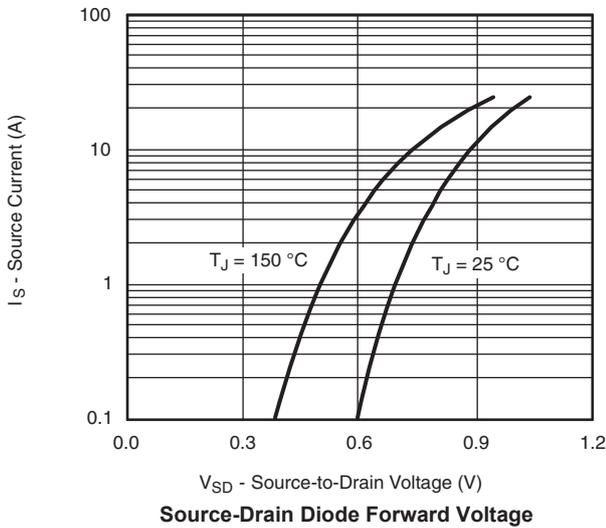
**Gate Charge**



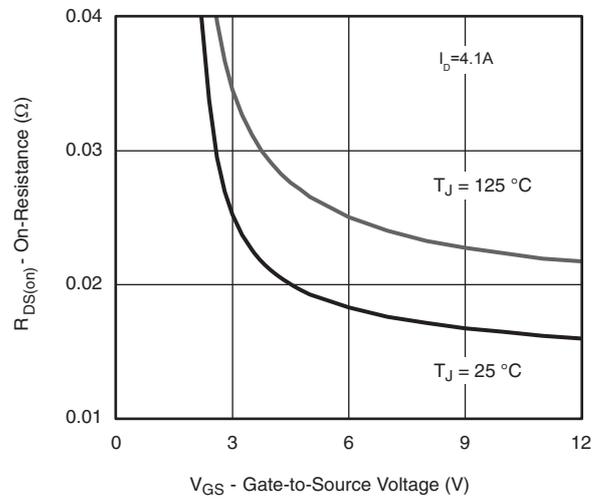
$T_J$  - Junction Temperature (°C)

**On-Resistance vs. Junction Temperature**

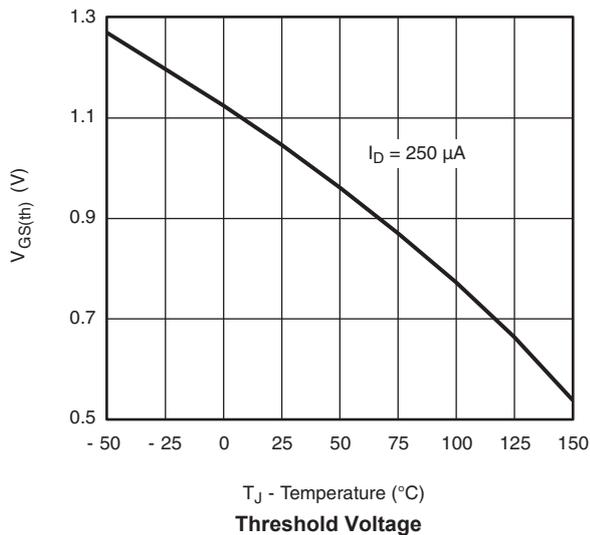
### TYPICAL TRANSIENT CHARACTERISTICS



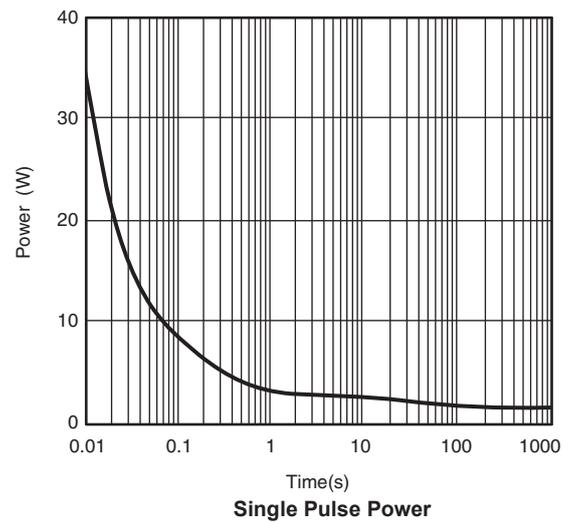
Source-Drain Diode Forward Voltage



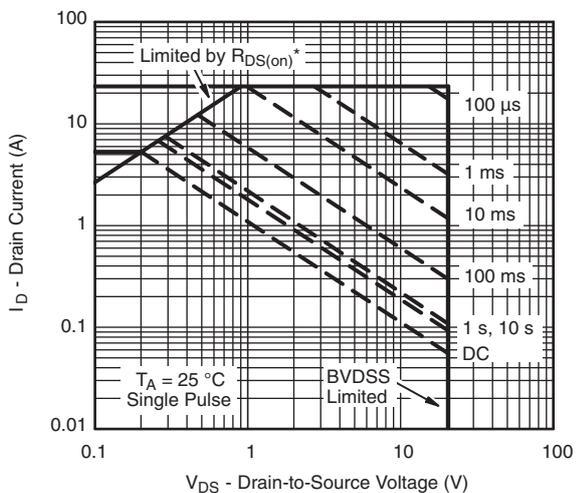
On-Resistance vs. Gate-to-Source Voltage



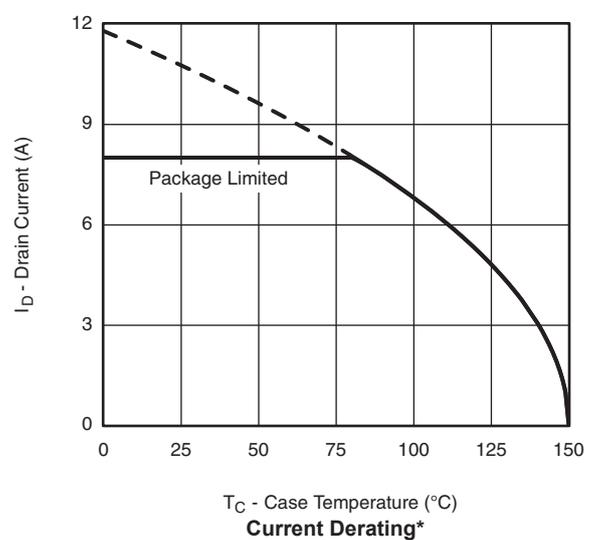
Threshold Voltage



Single Pulse Power



Safe Operating Area, Junction-to-Ambient



Current Derating\*

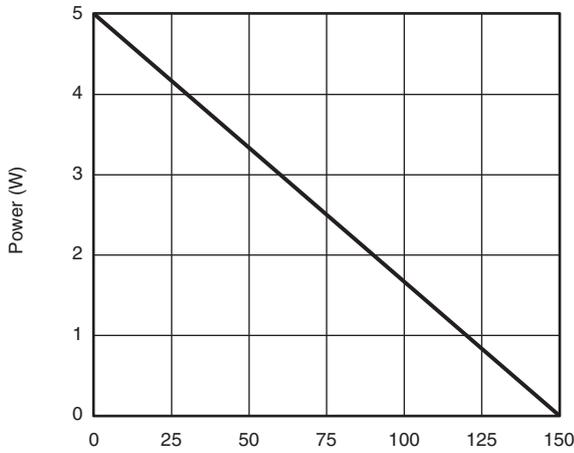


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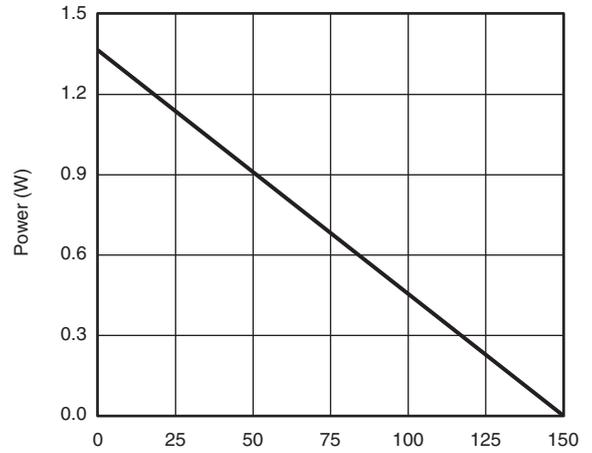
# HC3407A

## P-CHANNEL ENHANCEMENT MODE MOSFET

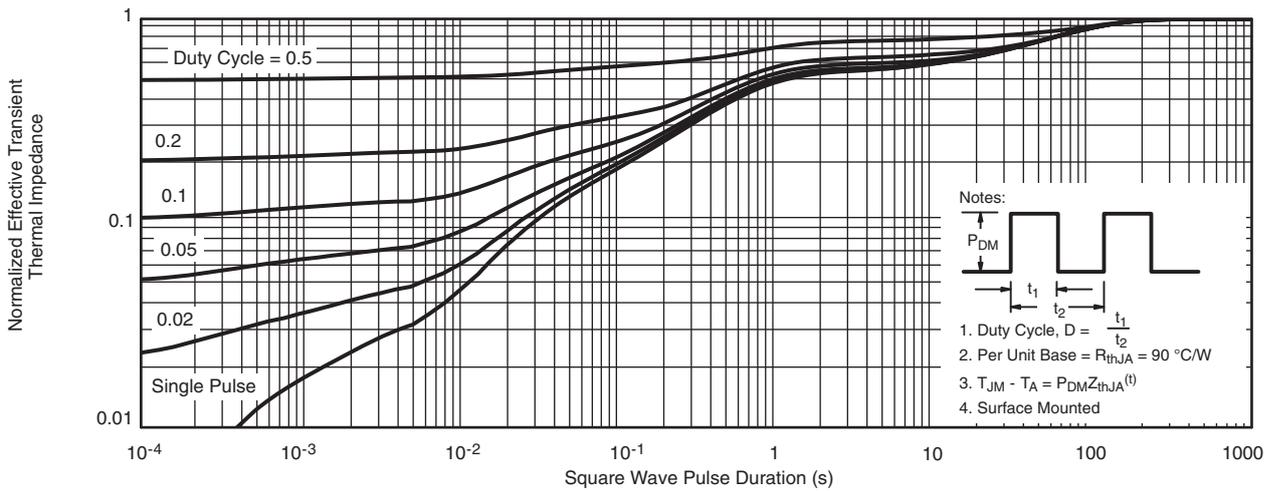
### TYPICAL TRANSIENT CHARACTERISTICS



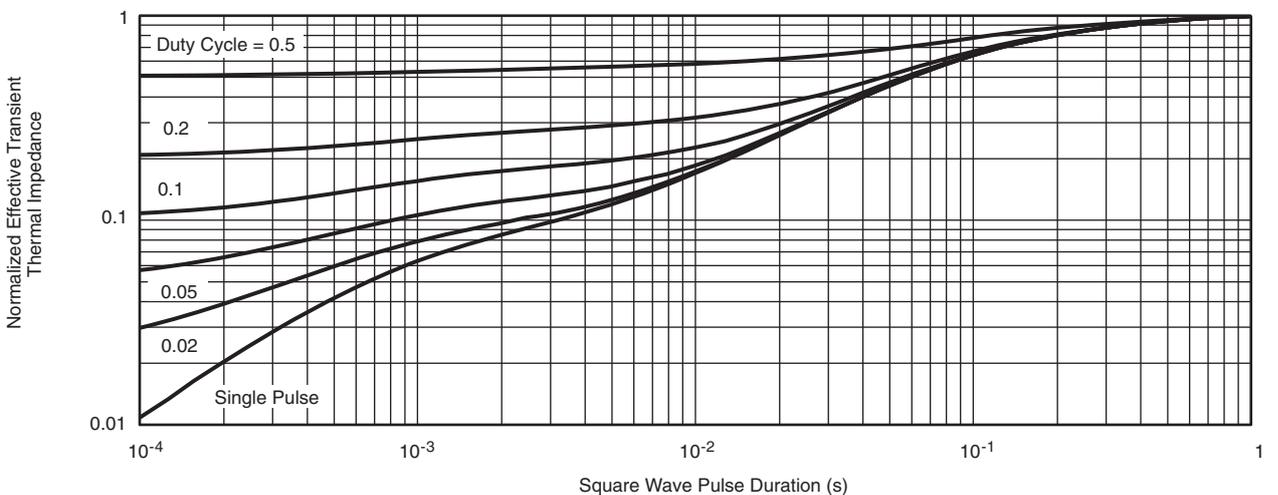
T<sub>C</sub> - Case Temperature (°C)  
Power Derating, Junction-to-Foot



T<sub>A</sub> - Ambient Temperature (°C)  
Power Derating, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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